2SK2276

Silicon N-Channel MOS

For switching

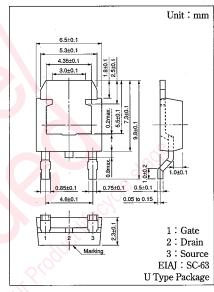
■ Features

- Low ON-resistance R_{DS(on)}
- High-speed switching

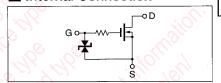
■ Absolute Maximum Ratings(Ta=25°C)

Parameter	Symbol	Rating	Unit	
Drain-Source breakdown voltage	V _{DSS}	60	V	
Gate-Source voltage	V _{GSS}	±20	V	
Drain current	I_{D}	±3	A	
Max drain current	I _{DP} *1	±5	A	
Allowable power dissipation	P _D *2	10	W	
Channel temperature	T _{ch}	150	°C	
Storage temperature	T _{stg}	-55 to $+150$	$^{\circ}$ C	

^{*1} $t \le 300 \,\mu\,\text{s}$, Duty Cycle < 10% *2 $T_C = 25^{\circ}\text{C}$

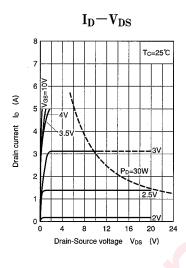


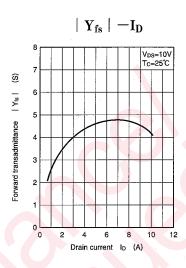
Internal Connection

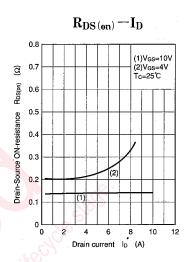


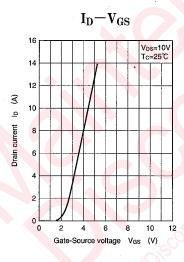
■ Electrical Characteristics (Ta=25°C)

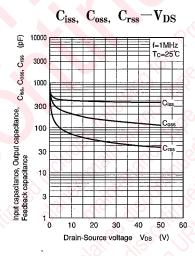
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Drain-Source cut-off current	I _{DSS}	$V_{DS} = 40V, V_{GS} = 0$		250	10	μA
Gate-Source leakage current	I _{GSS}	$V_{GS}=\pm 20V$, $V_{DS}=0$			土1	μΑ
Drain-Source breakdown voltage	$V_{\rm DSS}$	$I_D=1mA$, $V_{GS}=0$	60	5		v
Gate threshold voltage	V_{th}	$V_{DS}=10V$, $I_{D}=1mA$. 10	,	2.5	v
Drain-Source ON-resistance	R _{DS(on)}	$V_{GS}=10V$, $I_D=3A$		0.135	0.2	Ω
Forward transadmittance	Y _{fs}	$V_{DS}=10V$, $I_{D}=3A$	2.4	4		S
Input capacitance	C _{iss}	it and		400		pF
Output capacitance	Coss	$V_{DS}=10V$, $V_{GS}=0$, $f=1MHz$		210		pF
Feedback capacitance	Crss	SO 101/1		80		pF
Turn-on time	t _{on}	1802 Min		29		ns
Fall time	. t _f	$V_{GS} = 10V$, $I_D = 3A$, $R_L = 10\Omega$		53		ns
Turn-off time (delay time)	t _{d (off)}			97		ns

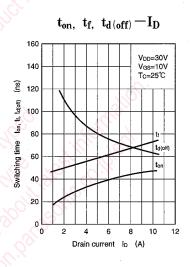


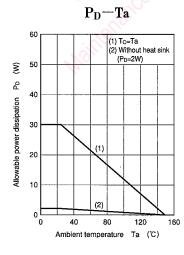


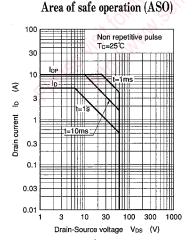


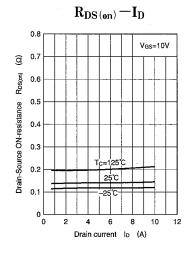












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